Random bad cell map for wafer 185 s/n: Y21316-09-07

Date: 07/12/99

		0	0		1	362		
		4	0		0	0		
	0	0	0		0	0	0	
	0	0		0	0	0	0	
0	0	1		0		0	0	0
0	0	0			4	0	0	
0	0	0	5		0	0	0	0
0	0	1			1	0	0	
		3	2		1		0	
1		0	1	8	1	0	0	
0	0	4	1	1	0	1	0	0
4	0	0	5	1		0	0	
0		4	1	5	0	0	0	0
5	0	0	0	1	0	0	0	0
	0	5	0	0	0	0	0	
	0	0	0	0	0	0	2	
		0		2	0	0		
		0			0	0		

#	Number of bad cells in random locations
	No info